

این دیتاشیت توسط توکل الکترونیک تهیه و ارائه شده است.
جهت مشاهده قیمت، موجودی و ثبت سفارش این قطعه به وبسایت توکل الکترونیک مراجعه فرمایید.



SILICONIX INC



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SMP60N06/05, SMP50N06/05

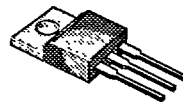
N-Channel Enhancement Mode Transistors

T-39-13

PRODUCT SUMMARY

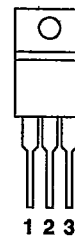
PART NUMBER	$V_{(BR)DSS}$ (V)	$r_{DS(ON)}$ (Ω)	I_D (A)
SMP60N06	60	0.023	60
SMP60N05	50	0.023	60
SMP50N06	60	0.028	50
SMP50N05	50	0.028	50

TO-220AB



- 1 GATE
2 DRAIN (Connected to TAB)
3 SOURCE

TOP VIEW



ABSOLUTE MAXIMUM RATINGS ($T_C = 25^\circ\text{C}$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS	SYMBOL	SMP				UNITS
		60N06	60N05	50N06	50N05	
Gate-Source Voltage	V_{GS}	± 20	± 20	± 20	± 20	V
Continuous Drain Current	$T_C = 25^\circ\text{C}$	I_D	60	60	50	A
	$T_C = 100^\circ\text{C}$		38	38	31	
Pulsed Drain Current ¹	I_{DM}	240	240	200	200	
Avalanche Current (See Figure 9)	I_{AR}	60	60	50	50	
Avalanche Energy	$L = 0.05\text{ mH}$	E_A	90	90	62	mJ
Repetitive Avalanche Energy ²	$L = 0.01\text{ mH}$	E_{AR}	18	18	18	
Power Dissipation	$T_C = 25^\circ\text{C}$	P_D	125	125	125	W
	$T_C = 100^\circ\text{C}$		50	50	50	
Operating Junction & Storage Temperature Range	T_J, T_{stg}	-55 to 150				$^\circ\text{C}$
Lead Temperature ($1/16"$ from case for 10 sec.)	T_L	300				

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THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Case	R_{thJC}		1.0	K/W
Junction-to-Ambient	R_{thJA}		80	
Case-to-Sink	R_{thCS}	1.0		

¹Pulse width limited by maximum junction temperature (refer to transient thermal Impedance data, Figure 11).

²Duty cycle $\leq 1\%$.

SMP60N06/05, SMP50N06/05**ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ Unless Otherwise Noted)****T-39-13**

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PARAMETER		SYMBOL	TEST CONDITIONS	TYP	LIMITS		UNIT
					MIN	MAX	
STATIC							
Drain-Source Breakdown Voltage	SMP60N06, 50N06 SMP50N06, 50N05	$V_{(BR)DSS}$	$V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$	65 55	60 50		V
Gate Threshold Voltage		$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$		2.0	4.0	
Gate-Body Leakage		I_{GSS}	$V_{DS} = 0\text{ V}, V_{GS} = \pm 20\text{ V}$	10		± 100	nA
Zero Gate Voltage Drain Current		I_{DSS}	$V_{DS} = V_{(BR)DSS}, V_{GS} = 0\text{ V}$			250	μA
			$V_{DS} = 0.8 \times V_{(BR)DSS}, V_{GS} = 0\text{ V}, T_J = 125^\circ\text{C}$			1000	
On-State Drain Current ¹	SMP60N06, 60N05 SMP50N06, 50N05	$I_{D(ON)}$	$V_{DS} = 25\text{ V}, V_{GS} = 10\text{ V}$		60 50		A
Drain-Source On-State Resistance ¹	SMP60N06, 60N05 SMP50N06, 50N05	$r_{DS(ON)}$	$V_{GS} = 10\text{ V}, I_D = 30\text{ A}$	0.019 0.023		0.023 0.028	Ω
	$V_{GS} = 10\text{ V}, I_D = 30\text{ A}$ $T_J = 125^\circ\text{C}$		0.025 0.030		0.030 0.036		
Forward Transconductance ¹		g_{fs}	$V_{DS} = 25\text{ V}, I_D = 30\text{ A}$	18	15		S
DYNAMIC							
Input Capacitance		C_{iss}	$V_{GS} = 0\text{ V}, V_{DS} = 25\text{ V}, f = 1\text{ MHz}$	2900			pF
Output Capacitance		C_{oss}		1500			
Reverse Transfer Capacitance		C_{rss}		500			
Total Gate Charge ²		Q_g	$V_{DS} = 0.5 \times V_{(BR)DSS}, V_{GS} = 10\text{ V}, I_D = 60\text{ A}$	70		100	nC
Gate-Source Charge ²		Q_{gs}		22		35	
Gate-Drain Charge ²		Q_{gd}		35		50	
Turn-On Delay Time ²		$t_{d(on)}$	$V_{DD} = 30\text{ V}, R_L = 1\text{ }\Omega$ $I_D \approx 130\text{ A}, V_{GEN} = 10\text{ V}, R_G = 2.5\text{ }\Omega$	20		40	ns
Rise Time ²		t_r		25		50	
Turn-Off Delay Time ²		$t_{d(off)}$		30		60	
Fall Time ²		t_f		20		40	
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS ($T_C = 25^\circ\text{C}$)							
Continuous Current	SMP60N06, 60N05 SMP50N06, 50N05	I_S				60 50	A
Pulsed Current ³		I_{SM}				190	
Forward Voltage ¹	SMP60N06, 60N05 SMP50N06, 50N05	V_{SD}	$I_F = I_S, V_{GS} = 0\text{ V}$			2.5 2.4	V
Reverse Recovery Time		t_{rr}	$I_F = I_S, dI_F/dt = 100\text{ A}/\mu\text{s}$	75		100	ns
Reverse Recovery Charge		Q_{rr}		0.19			μC

¹Pulse test: Pulse Width $\leq 300\text{ }\mu\text{sec}$, Duty Cycle $\leq 2\%$.²Independent of operating temperature.³Pulse width limited by maximum junction temperature (refer to transient thermal impedance data, Figure 11).

Figure 1. Output Characteristics

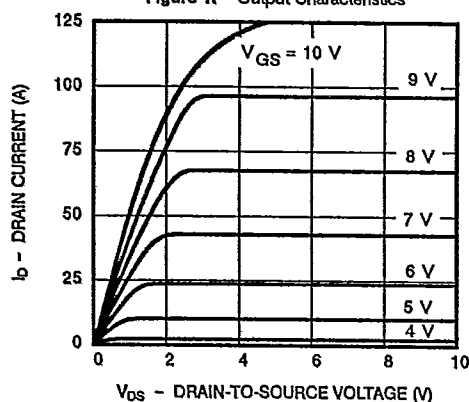


Figure 2. Transfer Characteristics

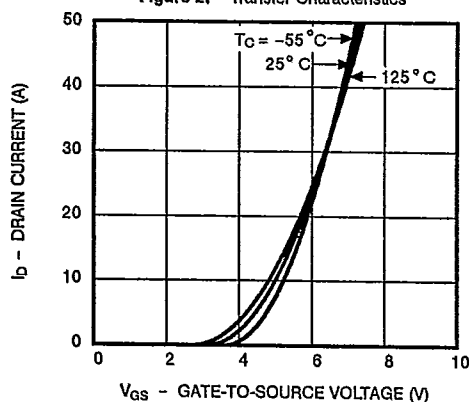


Figure 3. Transconductance

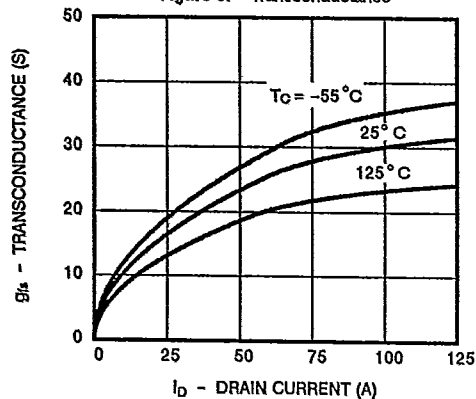


Figure 4. On-Resistance

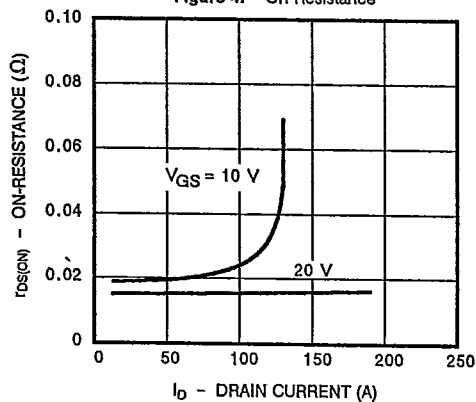


Figure 5. Capacitance

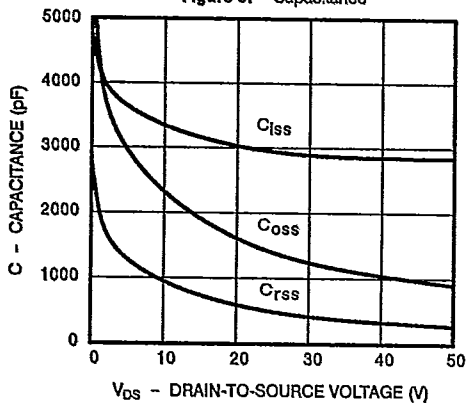
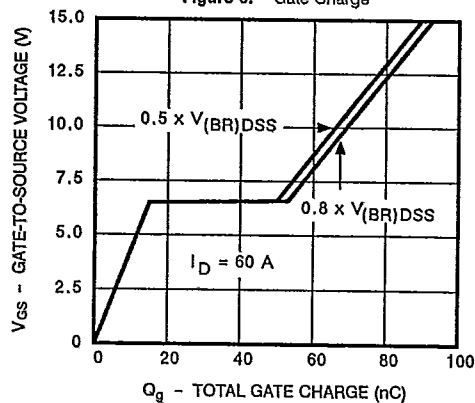


Figure 6. Gate Charge



SMP60N06/05, SMP50N06/05

TYPICAL CHARACTERISTICS (Cont'd)

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Figure 7. On-Resistance vs. Junction Temperature

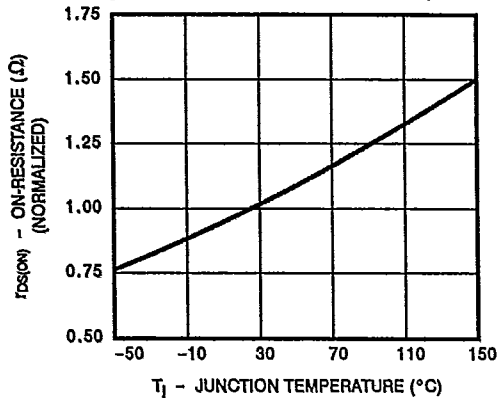


Figure 8. Source-Drain Diode Forward Voltage

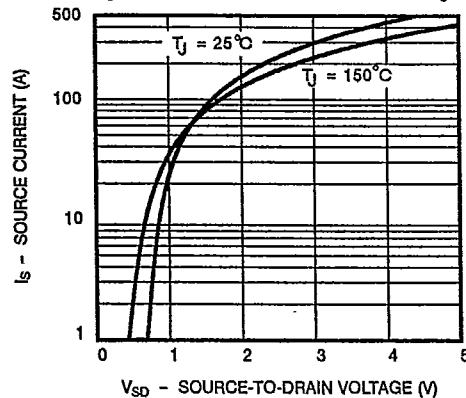
**THERMAL RATINGS**

Figure 9. Maximum Avalanche and Drain Current vs. Case Temperature

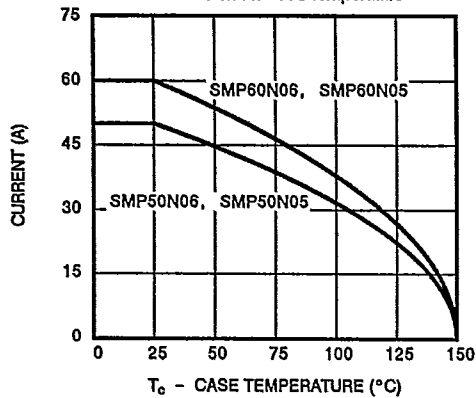


Figure 10. Safe Operating Area

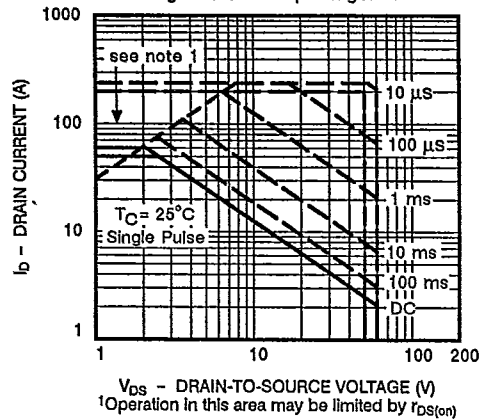


Figure 11. Normalized Effective Transient Thermal Impedance, Junction-to-Case

